

Ex: 5.2

$$C_{ox} = \frac{\epsilon_{ox}}{t_{ox}} = \frac{34.5 \text{ pF/m}}{4 \text{ nm}} = 2.30 \text{ fF}/\mu\text{m}^2$$

$$\mu_n = 550 \text{ cm}^2/\text{VS}$$

$$k'_n = \mu_n C_{ox} = 127 \text{ }\mu\text{A}/\text{V}^2$$

$$I_D = \frac{1}{2} k'_n \frac{W}{L} V_{ov}^2 = 0.2 \text{ mA}, \frac{W}{L} = 20$$

$$\therefore V_{OV} = 0.40 \text{ V.}$$

$$V_{Ds, \min} = V_{OV} = 0.40 \text{ V, for saturation}$$

5.5 The transistor size will be minimized if W/L is minimized, since W/L appears in the equations that must be satisfied, we can minimize (W/L) . Clearly we want to minimize L by using the smallest feature size.

$$L = 0.18 \mu\text{m}$$

$$r_{DS} = \frac{1}{k_n'(W/L)(v_{GS} - V_T)}$$

$$r_{DS} = \frac{1}{k_n'(W/L)v_{OV}}$$

Two conditions need to be met for v_{OV} and r_{DS}

Condition 1:

$$\begin{aligned} r_{DS,1} &= \frac{1}{400 \times 10^{-6} (W/L) v_{OV,1}} \\ &= 200 \Rightarrow (W/L) v_{OV,1} = 12.5 \end{aligned}$$

Condition 2:

$$\begin{aligned} r_{DS,2} &= \frac{1}{400 \times 10^{-6} (W/L) v_{OV,2}} \\ &= 1000 \Rightarrow (W/L) v_{OV,2} = 2.5 \end{aligned}$$

If condition 1 is met, condition 2 will be met since the over-voltage can always be reduced to satisfy this requirement. For condition 1, we want to decrease W/L as much as possible (so long as it is greater than or equal to 1), while still meeting all of the other constraints.

This requires our using the largest possible $v_{GS,1}$ voltage. $v_{GS,1} = 1.8$ Volts, so $v_{OV,1} = 1.4$ Volts that

$$W/L = \frac{12.5}{v_{OV,1}} = \frac{12.5}{1.4} \cong 8.93$$

Condition 2 now can be used to find $v_{GS,2}$

$$v_{OV,2} = \frac{12.5}{W/L} = \frac{2.5}{12.5/1.4} = 0.28$$

$$\Rightarrow v_{GS,2} = 0.68 \text{ Volts} \Rightarrow 0.68 \leq v_{GS} \leq 1.8$$